# Power MOSFET and Schottky Diode

-20 V, FETKY<sup>™</sup>, P-Channel, -4.4 A, with 3.7 A Schottky Barrier Diode, ChipFET<sup>™</sup>

#### **Features**

- Leadless SMD Package Featuring a MOSFET and Schottky Diode
- 40% Smaller than TSOP-6 Package
- Leadless SMD Package Provides Great Thermal Characteristics
- Independent Pinout to each Device to Ease Circuit Design
- Trench P-Channel for Low On Resistance
- Ultra Low V<sub>F</sub> Schottky
- These are Pb-Free Devices

#### **Applications**

- Li-Ion Battery Charging
- High Side DC-DC Conversion Circuits
- High Side Drive for Small Brushless DC Motors
- Power Management in Portable, Battery Powered Products

### MOSFET MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Parameter				Units
Drain-to-Source Voltag	$V_{DSS}$	-20	V		
Gate-to-Source Voltage	)		$V_{GS}$	±8.0	V
Continuous Drain	Steady	T <sub>J</sub> = 25°C	I <sub>D</sub>	-3.2	Α
Current (Note 1)	State	T <sub>J</sub> = 85°C		-2.3	
	t ≤ 5 s	T <sub>J</sub> = 25°C		-4.4	
Power Dissipation (Note 1)	Steady State T <sub>.1</sub> = 25°C		P <sub>D</sub>	1.1	W
	t ≤ 5 s			2.1	
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-13	Α
Operating Junction and	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C		
Source Current (Body D	I <sub>S</sub>	2.5	Α		
Lead Temperature for So (1/8" from case for 1		urposes	TL	260	°C

#### **SCHOTTKY DIODE MAXIMUM RATINGS**

(T<sub>1</sub> = 25°C unless otherwise noted)

(.g == c amos carermos notas)									
Para	Symbol	Value	Units						
Peak Repetitive Rever	$V_{RRM}$	20	V						
DC Blocking Voltage	$V_{R}$	20	V						
Average Rectified Forward Current	Ι <sub>F</sub>	2.2	٧						
		3.7	Α						

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



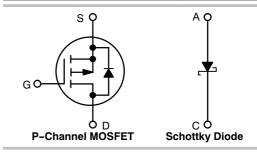
## ON Semiconductor®

http://onsemi.com

MOSFET						
V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> TYP I <sub>D</sub> MA						
-20 V	64 mΩ @ -4.5 V	4.4.4				
	85 mΩ @ -2.5 V	-4.4 A				

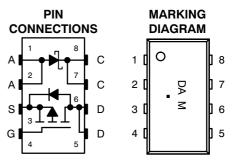
#### **SCHOTTKY DIODE**

V <sub>R</sub> MAX	V <sub>F</sub> TYP	I <sub>F</sub> MAX
20 V	0.35 V	3.7 A





ChipFET CASE 1206A STYLE 3



DA = Specific Device Code
M = Month Code
Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	113	°C/W
Junction-to-Ambient – $t \le 10 \text{ s}$ (Note 2)	$R_{ hetaJA}$	60	°C/W

<sup>2.</sup> Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

## MOSFET ELECTRICAL CHARACTERISTICS ( $T_J = 25$ °C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Units
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -$	-250 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				-15		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -16 V, V <sub>GS</sub> = 0 V	$T_J = 25^{\circ}C$			-1.0	μΑ
		V <sub>GS</sub> = 0 V	T <sub>J</sub> = 125°C			-5.0	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8.0 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	-250 μΑ	-0.45		-1.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.7		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5$ , $I_D = -3.2$ A $V_{GS} = -2.5$ , $I_D = -2.2$ A $V_{GS} = -1.8$ , $I_D = -1.0$ A			64	80	mΩ
					85	110	1
					120	170	1
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V}, I_D = -2.9 \text{ A}$			8.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$			680		pF
Output Capacitance	C <sub>OSS</sub>				100		1
Reverse Transfer Capacitance	C <sub>RSS</sub>	VDS = -10	V		70		1
Total Gate Charge	Q <sub>G(TOT)</sub>				7.4		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub>	s = -10 V,		0.6		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS}$ $I_{D} = -3.2 \text{ J}$	Á		1.4		1
Gate-to-Drain Charge	$Q_{GD}$	1			2.5		1
SWITCHING CHARACTERISTICS (Note 4	1)						
Turn-On Delay Time	t <sub>d(ON)</sub>				5.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub>	n = −10 V.		11.7		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -3.2 \text{ A, R}_G$			16		1
Fall Time	t <sub>f</sub>	1			12.4		1
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_{S} = -2.5 \text{ A}$	T <sub>J</sub> = 25°C		-0.8	-1.2	V
Reverse Recovery Time	t <sub>RR</sub>				13.5		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } I_{S} = -1.0 \text{ A },$ $dI_{S}/dt = 100 \text{ A/}\mu\text{s}$			9.5		1
Discharge Time	t <sub>b</sub>				4.0		1
Reverse Recovery Charge	Q <sub>RR</sub>				6.5		nC

## SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 0.1 A			0.31	V
Forward Voltage		I <sub>F</sub> = 1.0 A			0.365	
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> = 10 V			0.75	mA
Reverse Current		V <sub>R</sub> = 20 V			2.5	
Non-Repetitive Peak Surge Current	I <sub>FSM</sub>	Halfwave, Single Pulse 60 Hz			23	Α

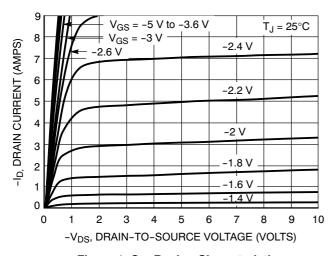
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### TYPICAL P-CHANNEL PERFORMANCE CURVES

(T<sub>J</sub> = 25°C unless otherwise noted)

 $V_{DS} \ge -10 \text{ V}$ 

8

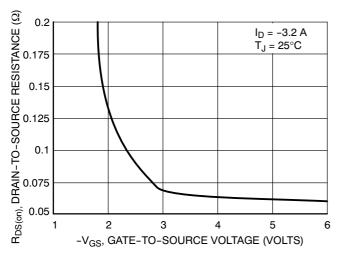


I<sub>D.</sub> DRAIN CURRENT (AMPS) 7 6 5 4 3  $T_C = -55^{\circ}C$ 2 25°C 100°C 0 0 0.5 1.5 2.5 3 3.5 2

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

-V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)



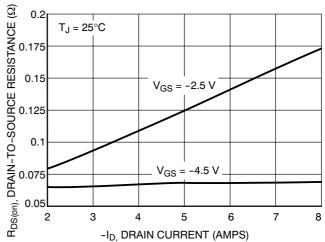
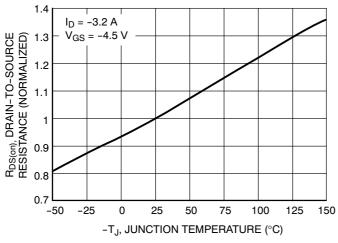


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



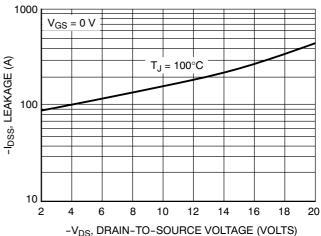
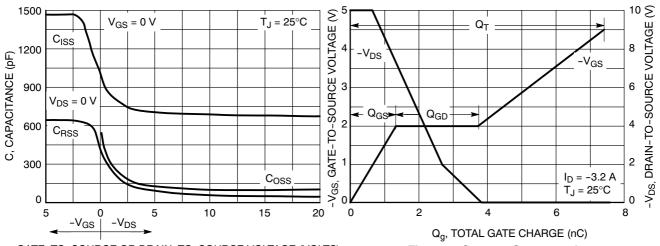


Figure 5. On-Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

### **TYPICAL P-CHANNEL PERFORMANCE CURVES**

(T<sub>J</sub> = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

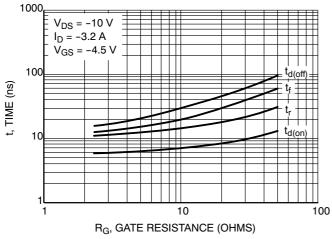


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

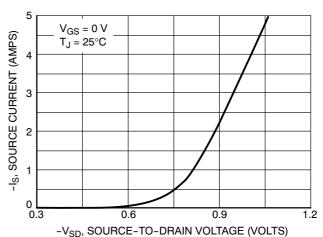
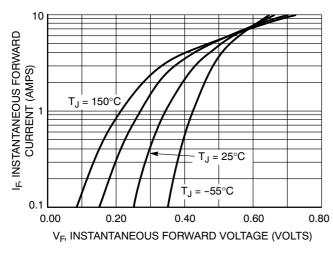


Figure 10. Diode Forward Voltage vs. Current

### TYPICAL SCHOTTKY PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



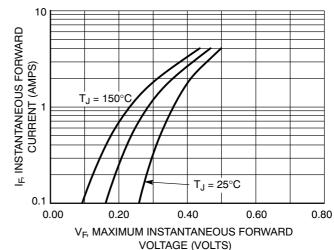
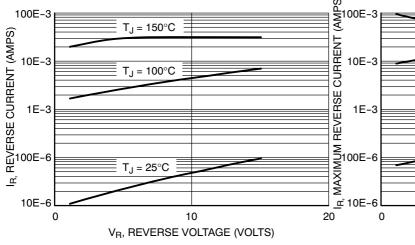


Figure 11. Typical Forward Voltage

Figure 12. Maximum Forward Voltage



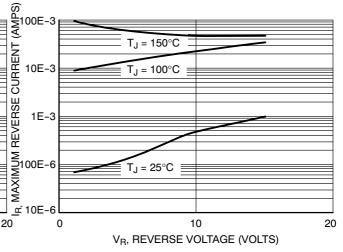
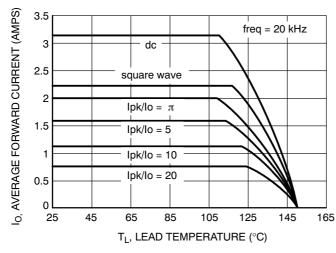


Figure 13. Typical Reverse Current

Figure 14. Maximum Reverse Current





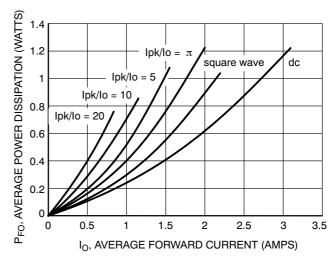


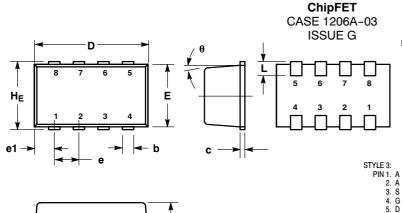
Figure 16. Forward Power Dissipation

## **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTHD3133PFT1G	ChipFET (Pb-Free)	3000 / Tape & Reel
NTHD3133PFT3G	ChipFET (Pb-Free)	10000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



0.05 (0.002)

#### NOTES:

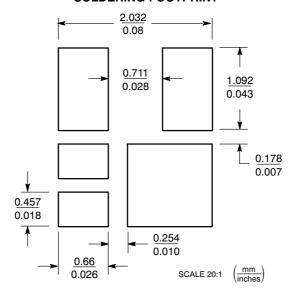
6. D 7. C 8. C

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
  MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
  LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL
- AND VERTICAL SHALL NOT EXCEED 0.08 MM.
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.00	1.05	1.10	0.039	0.041	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
C	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
Е	1.55	1.65	1.70	0.061	0.065	0.067
_	0.65 BSC				0 025 BSC	,

Α	1.00	1.05	1.10	0.039	0.041	0.043		
b	0.25	0.30	0.35	0.010	0.012	0.014		
С	0.10	0.15	0.20	0.004	0.006	0.008		
D	2.95	3.05	3.10	0.116	0.120	0.122		
E	1.55	1.65	1.70	0.061	0.065	0.067		
е		0.65 BSC			0.025 BSC			
e1		0.55 BSC			0.022 BSC			
L	0.28	0.35	0.42	0.011	0.014	0.017		
HE	1.80	1.90	2.00	0.071	0.075	0.079		
θ	5° NOM				5° NOM			

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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